

## STD8N10L

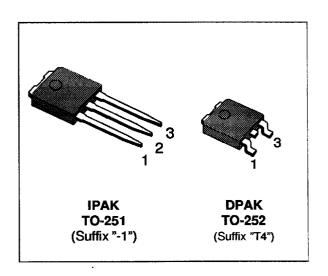
# N - CHANNEL ENHANCEMENT MODE LOW THRESHOLD POWER MOS TRANSISTOR

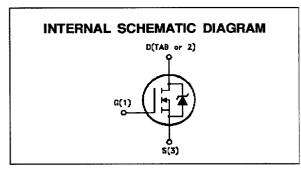
| TYPE     | Voss  | RDS(on)  | lo  |
|----------|-------|----------|-----|
| STD8N10L | 100 V | < 0.33 Ω | 8 A |

- TYPICAL  $R_{DS(on)} = 0.25 \Omega$
- AVALANCHE RUGGED TECHNOLOGY
- 100% AVALANCHE TESTED
- REPETITIVE AVALANCHE DATA AT 100°C
- LOW GATE CHARGE
- HIGH CURRENT CAPABILITY
- 175°C OPERATING TEMPERATURE
- APPLICATION ORIENTED CHARACTERIZATION
- THROUGH-HOLE IPAK (TO-251) POWER PACKAGE IN TUBE (SUFFIX "-1")
- SURFACE-MOUNTING DPAK (TO-252)
   POWER PACKAGE IN TAPE & REEL (SUFFIX "T4")

#### **APPLICATIONS**

- HIGH CURRENT, HIGH SPEED SWITCHING
- SOLENOID AND RELAY DRIVERS
- REGULATORS
- DC-DC & DC-AC CONVERTERS
- MOTOR CONTROL, AUDIO AMPLIFIERS
- AUTOMOTIVE ENVIRONMENT (INJECTION, ABS, AIR-BAG, LAMPDRIVERS, Etc.)





#### **ABSOLUTE MAXIMUM RATINGS**

| Symbol              | Parameter   | Value      | Unit |
|---------------------|---|------------|------|
| V <sub>DS</sub> .   | Drain-source Voltage (V <sub>GS</sub> = 0)            | 100        | ٧    |
| VDGR                | Drain- gate Voltage (R <sub>GS</sub> = 20 kΩ)         | 100        | ٧    |
| V <sub>GS</sub>     | Gate-source Voltage                                   | ± 15       | V    |
| I <sub>D</sub>      | Drain Current (continuous) at T <sub>c</sub> = 25 °C  | 8          | A    |
| I <sub>D</sub>      | Drain Current (continuous) at T <sub>c</sub> = 100 °C | 5.5        | Α    |
| I <sub>DM</sub> (•) | Drain Current (pulsed)                                | 32         | Α    |
| Ptot                | Total Dissipation at T <sub>c</sub> = 25 °C           | 45         | W    |
|                     | Derating Factor                                       | 0.3        | W/°C |
| T <sub>stg</sub>    | Storage Temperature                                   | -65 to 175 | °C   |
| Tj                  | Max. Operating Junction Temperature                   | 175        | °C   |

(•) Pulse width limited by safe operating area

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### STD8N10L

#### THERMAL DATA

| ſ | R <sub>thi-case</sub> | Thermal Resistance | Junction-case              | Max   | 3.33 | °C/W |
|---|-----------------------|--------------------|----------------------------|-------|------|------|
| ١ |                       | Thermal Resistance | Junction-ambient           | Max   | 100  | °C/W |
| ١ | Rthc-sink             | Thermal Resistance | Case-sink                  | Тур   | 1.5  | °C/W |
| ١ | Tı                    | Maximum Lead Ten   | nperature For Soldering Pu | rpose | 275  | °C   |

#### **AVALANCHE CHARACTERISTICS**

| Symbol | Parameter  | Max Value | Unit |
|--------|--|-----------|------|
| IAR    | Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by $T_j$ max, $\delta$ < 1%)  | 8         | А    |
| EAS    | Single Pulse Avalanche Energy (starting $T_j = 25$ °C, $I_D = I_{AR}$ , $V_{DD} = 25$ V)   | 25        | mJ   |
| EAR    | Repetitive Avalanche Energy (pulse width limited by T <sub>j</sub> max, δ < 1%)  | 6         | mJ   |
| lar    | Avalanche Current, Repetitive or Not-Repetitive $(T_c = 100  ^{\circ}\text{C}, \text{ pulse width limited by T}_{j}  \text{max},  \delta < 1\%)$ | 5.5       | А    |

# **ELECTRICAL CHARACTERISTICS** ( $T_{case} = 25$ °C unless otherwise specified) OFF

| Symbol Parameter     |  | Test Conditions  | Min. | Тур. | Max.        | Unit     |  |
|----------------------|--|--|------|------|-------------|----------|--|
| V <sub>(BR)Dss</sub> | Drain-source<br>Breakdown Voltage                  | $I_D = 250 \mu\text{A}$ $V_{GS} = 0$                             | 100  |      |             | ٧        |  |
| I <sub>DSS</sub>     | Zero Gate Voltage<br>Drain Current (Vgs = 0)       | $V_{DS}$ = Max Rating $V_{DS}$ = Max Rating x 0.8 $T_c$ = 125 °C |      |      | 250<br>1000 | μA<br>μA |  |
| lass                 | Gate-body Leakage<br>Current (V <sub>DS</sub> = 0) | V <sub>GS</sub> = ± 15 V   |      |      | ± 100       | nA       |  |

### ON (\*)

| Symbol              | Parameter                         | Test Conditions   | Min. | Тур. | Max.         | Unit |
|---------------------|-----------------------------------|---|------|------|--------------|------|
| V <sub>GS(th)</sub> | Gate Threshold Voltage            | V <sub>DS</sub> = V <sub>GS</sub> I <sub>D</sub> = 250 μA   | 1    | 1.6  | 2.5          | ٧    |
| R <sub>DS(on)</sub> | Static Drain-source On Resistance | V <sub>GS</sub> = 5 V I <sub>D</sub> = 4 A<br>V <sub>GS</sub> = 5 V I <sub>D</sub> = 4 A T <sub>c</sub> = 100°C |      | 0.25 | 0.33<br>0.66 | Ω    |
| ID(on)              | On State Drain Current            | VDS > ID(on) x RDS(on)max<br>VGS = 10 V   | 8    |      |              | Α    |

#### **DYNAMIC**

| Symbol               | Parameter  | Test Conditions                                       | Min. | Тур.            | Max.             | Unit           |
|----------------------|--|---|------|-----------------|------------------|----------------|
| <b>g</b> fs (*)      | Forward<br>Transconductance  | $V_{DS} > I_{D(on)} \times R_{DS(on)max}$ $I_D = 4 A$ | 3    | 7               |                  | S              |
| Ciss<br>Coss<br>Crss | Input Capacitance<br>Output Capacitance<br>Reverse Transfer<br>Capacitance | V <sub>DS</sub> = 25 V f = 1 MHz V <sub>GS</sub> = 0  |      | 430<br>90<br>20 | 650<br>150<br>30 | pF<br>pF<br>pF |

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#### **ELECTRICAL CHARACTERISTICS** (continued)

#### **SWITCHING ON**

| Symbol             | Parameter  | Test Conditions   | Min. | Тур.         | Max.      | Unit           |
|--------------------|--|---|------|--------------|-----------|----------------|
| t <sub>d(on)</sub> | Turn-on Time<br>Rise Time                                    | $V_{DD} = 50 \text{ V}$ $I_D = 4 \text{ A}$ $R_G = 50 \Omega$ $V_{GS} = 5 \text{ V}$ (see test circuit, figure 3) |      | 45<br>140    | 65<br>200 | ns<br>ns       |
| (di/dt)on          | Turn-on Current Slope  | $V_{DD} = 80 \text{ V}$ $I_D = 8 \text{ A}$ $R_G = 50 \Omega$ $V_{GS} = 5 \text{ V}$ (see test circuit, figure 5) |      | 95           |           | A/µs           |
| Qg<br>Qgs<br>Qgd   | Total Gate Charge<br>Gate-Source Charge<br>Gate-Drain Charge | V <sub>DD</sub> = 80 V I <sub>D</sub> = 8 A V <sub>GS</sub> = 5 V   |      | 12<br>5<br>4 | 20        | nC<br>nC<br>nC |

#### **SWITCHING OFF**

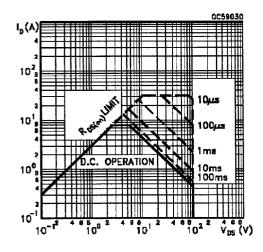
| Symbol               | Parameter             | Test Conditions                             | Min. | Тур. | Max. | Unit |
|----------------------|-----------------------|---|------|------|------|------|
| t <sub>r(Voff)</sub> | Off-voltage Rise Time | V <sub>DD</sub> = 80 V I <sub>D</sub> = 8 A |      | 50   | 70   | ns   |
| ` <b>t</b> f         | Fall Time             | $R_G = 50 \Omega  V_{GS} = 5 V$             | 1    | 50   | 70   | ns   |
| t <sub>c</sub>       | Cross-over Time       | (see test circuit, figure 5)                |      | 100  | 140  | ns   |

#### **SOURCE DRAIN DIODE**

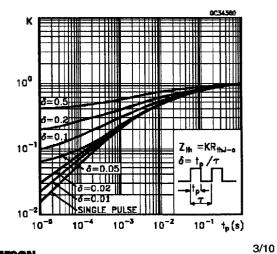
| Symbol                                  | Parameter  | Test Conditions  | Min. | Тур. | Max.    | Unit   |
|---|--|--|------|------|---------|--------|
| I <sub>SD</sub><br>I <sub>SDM</sub> (•) | Source-drain Current<br>Source-drain Current<br>(pulsed) |  |      |      | 8<br>32 | A<br>A |
| V <sub>SD</sub> (*)                     | Forward On Voltage                                       | I <sub>SD</sub> = 8 A V <sub>GS</sub> = 0  |      |      | 1.5     | V      |
| t <sub>rr</sub>                         | Reverse Recovery<br>Time                                 | I <sub>SD</sub> = 8 A di/dt = 100 A/μs<br>V <sub>DD</sub> = 50 V T <sub>i</sub> = 150 °C |      | 80   |         | ns     |
| $Q_{rr}$                                | Reverse Recovery Charge                                  | (see test circuit, figure 5)   |      | 0.24 |         | μC     |
| IRRM                                    | Reverse Recovery Current                                 |  |      | 6    |         | Α      |

<sup>(\*)</sup> Pulsed: Pulse duration = 300 μs, duty cycle 1.5 %
(•) Pulse width limited by safe operating area

#### Safe Operating Area



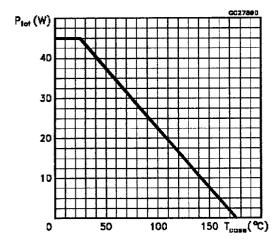
#### Thermal Impedance



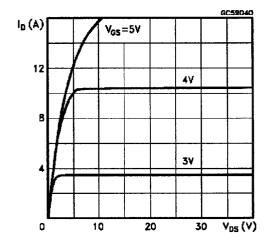
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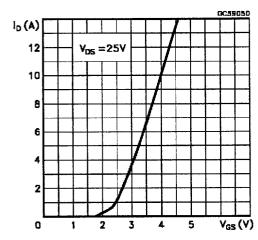
#### **Derating Curve**

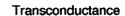


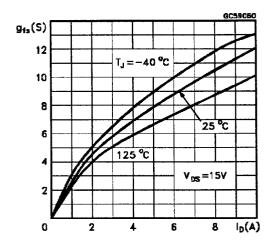
#### **Output Characteristics**



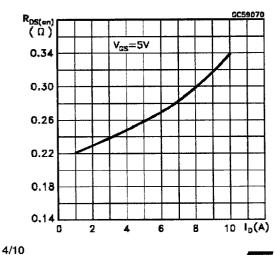
**Transfer Characteristics** 



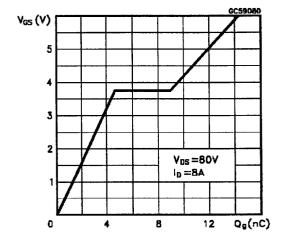




Static Drain-source On Resistance



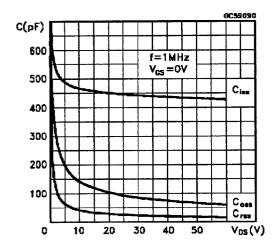
Gate Charge vs Gate-source Voltage



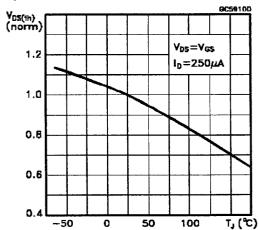
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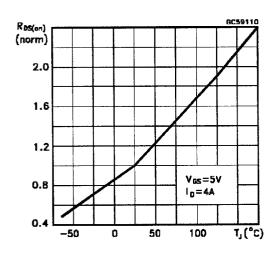
#### Capacitance Variations



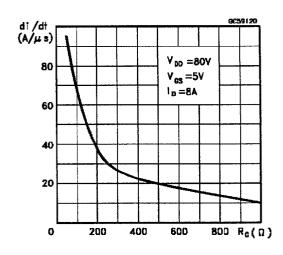
# Normalized Gate Threshold Voltage vs Temperature



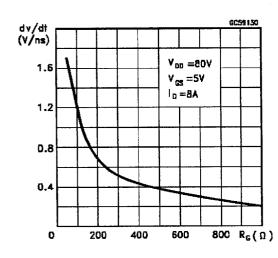
Normalized On Resistance vs Temperature



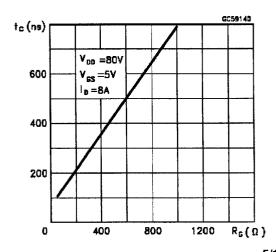
**Tum-on Current Slope** 



Turn-off Drain-source Voltage Slope



**Cross-over Time** 

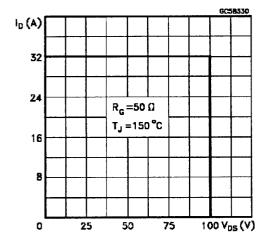


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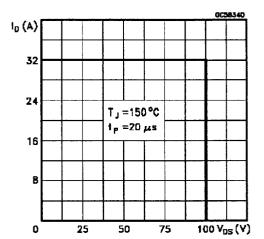
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#### Switching Safe Operating Area



#### Accidental Overload Area



Source-drain Diode Forward Characteristics

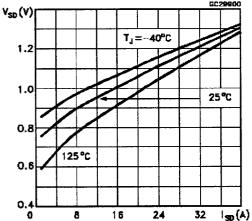


Fig. 1: Unclamped Inductive Load Test Circuits

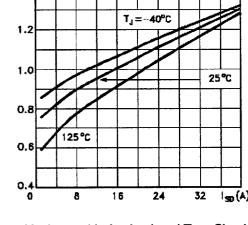
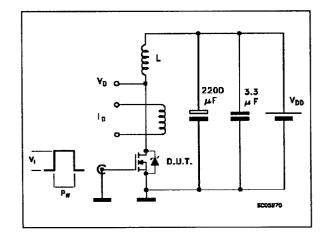
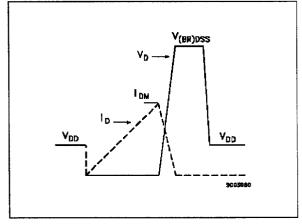


Fig. 2: Unclamped Inductive Waveforms





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Fig. 3: Switching Times Test Circuits For Resistive Load

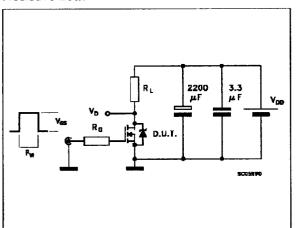


Fig. 4: Gate Charge Test Circuit

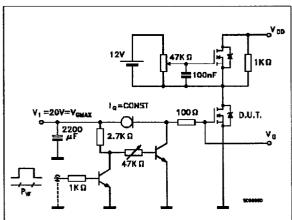
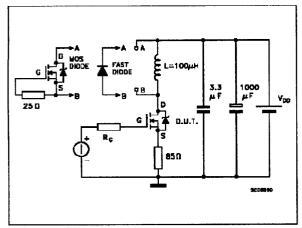
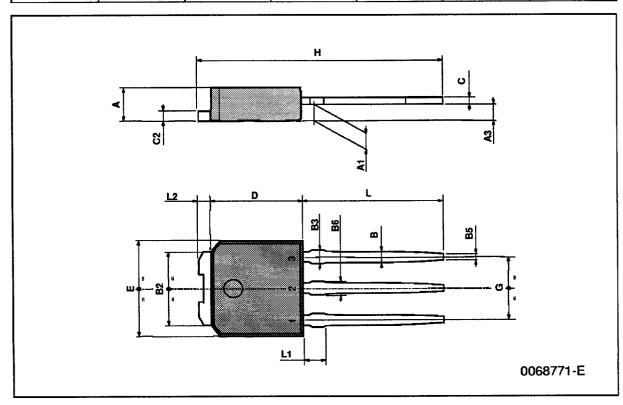


Fig. 5: Test Circuit For Inductive Load Switching And Diode Recovery Times



# TO-251 (IPAK) MECHANICAL DATA

| DIM  |      | mm   |      |       | inch  |       |
|------|------|------|------|-------|-------|-------|
| DIM. | MIN. | TYP. | MAX. | MIN.  | TYP.  | MAX.  |
| Α    | 2.2  |      | 2.4  | 0.086 |       | 0.094 |
| A1   | 0.9  |      | 1.1  | 0.035 |       | 0.043 |
| А3   | 0.7  |      | 1.3  | 0.027 |       | 0.051 |
| В    | 0.64 |      | 0.9  | 0.025 |       | 0.031 |
| B2   | 5.2  |      | 5.4  | 0.204 |       | 0.212 |
| B3   |      |      | 0.85 |       |       | 0.033 |
| B5   |      | 0.3  |      |       | 0.012 |       |
| B6   |      |      | 0.95 |       |       | 0.037 |
| С    | 0.45 |      | 0.6  | 0.017 |       | 0.023 |
| C2   | 0.48 |      | 0.6  | 0.019 |       | 0.023 |
| D    | 6    |      | 6.2  | 0.236 |       | 0.244 |
| E    | 6.4  |      | 6.6  | 0.252 |       | 0.260 |
| G    | 4.4  |      | 4.6  | 0.173 |       | 0.181 |
| Н    | 15.9 |      | 16.3 | 0.626 |       | 0.641 |
| L    | 9    |      | 9.4  | 0.354 |       | 0.370 |
| L1   | 0.8  |      | 1.2  | 0.031 |       | 0.047 |
| L2   |      | 0.8  | 1    |       | 0.031 | 0.039 |



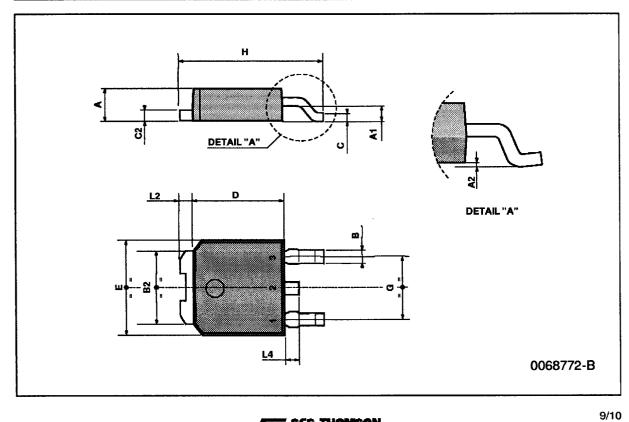
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## TO-252 (DPAK) MECHANICAL DATA

| DIM.  |      | mm inc |      |       | inch  |       |
|-------|------|--------|------|-------|-------|-------|
| Diwi. | MIN. | TYP.   | MAX. | MIN.  | TYP.  | MAX.  |
| Α     | 2.2  |        | 2.4  | 0.086 |       | 0.094 |
| A1    | 0.9  |        | 1.1  | 0.035 |       | 0.043 |
| A2    | 0.03 |        | 0.23 | 0.001 |       | 0.009 |
| В     | 0.64 |        | 0.9  | 0.025 |       | 0.035 |
| B2    | 5.2  |        | 5.4  | 0.204 |       | 0.212 |
| С     | 0.45 |        | 0.6  | 0.017 |       | 0.023 |
| C2    | 0.48 |        | 0.6  | 0.019 |       | 0.023 |
| D     | 6    |        | 6.2  | 0.236 |       | 0.244 |
| E     | 6.4  |        | 6.6  | 0.252 |       | 0.260 |
| G     | 4.4  |        | 4.6  | 0.173 |       | 0.181 |
| Н     | 9.35 |        | 10.1 | 0.368 |       | 0.397 |
| L2    |      | 0.8    |      |       | 0.031 |       |
| L4    | 0.6  |        | 1    | 0.023 | ·     | 0.039 |



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